

DAC018N120ZZ3

Silicon Carbide Enhancement Mode MOSFET

Features

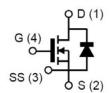
- High blocking voltage with low Rds(on)
- High frequency operation with low Capacitance
- Simple to drive with -4V/+15V gate
- · Robust body diode with low Qrr
- 100% Avalanche Tested

Benefits

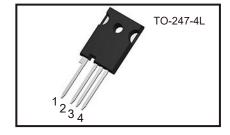
- Superior robustness and system reliability
- Higher system efficiency
- Easier paralleling without thermal runaway
- Capable of high temperature application
- Faster and more efficient switching

Applications

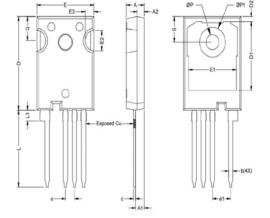
- EV motor drives
- EV/HEV charging station
- Energy storage and Battery charging
- High voltage DC-DC converters
- Solar / Wind Inverters
- UPS and PFC







Package Dimensions



DIM	MILLIMETERS				
	MIN	TYP.	MAX		
Α	4.82	5.02	5.22		
A1	2.21	2.41	2.61		
A2	1.8	2	2.2		
b	0.95	1.2	1.45		
b1	1.95	2.2	2.45		
b2	2.95	3.2	3.45		
С	0.35	0.6	0.85		
D	22.34	22.54	22.74		
D1	16.3	16.55	16.8		
D2	0.99	1.19	1.39		
E	15.74	15.94	16.14		
E1	13.01	13.26	13.51		
E2	4.71	4.91	5.11		
E3	2.26	2.46	2.66		
е	2.54BSC.				
e1	5.08BSC.				
L	18.23	18.48	18.73		
L1	2.35	2.60	2.85		
Р	3.41	3.61	3.81		
P1	6.94	7.19	7.44		
Q	5.59	5.79	5.99		
S	5.97	6.17	6.37		

Absolute Maximum Ratings

(Tc = 25°C unless otherwise specified)

Parameter	Symbol	Ratings	Unit	
Drain-Source Voltage	V _{GS} =0V I _D =100µA	V _{DS}	1200	V
Gate-Source Voltage (dynamic) d	AC (f>1 Hz, duty cycle<1%, oulse width<200ns)	V_{GS}	-8/+19	V
Gate-Source Voltage (static)	$V_{\text{GS(op)}}$	-4/+15	V	
Drain Current-Continuous	=18V@ T _C =25°C =18V@ T _C =100°C	I _D	125 90	Α
Pulse Drain Current		I _{D,pulse}	250	Α
Power Dissipation	P_D	577	W	
Storage Temperature Range	T _{STG}	-55 to +175	°C	
Operating Junction Temperature	TJ	-55 to +175	°C	
Soldering Temperature	TL	260	°C	
Avalanche Capability, single pulse	* V _{DD} =100V * V _{GS} =10V L=2mH	I _{AV}	46	А
Avalanche Capability, single pulse*	V _{DD} =100V * V _{GS} =10V L=2mH	E _{AV}	2300	mJ

^{* 100%} tested in 60% rating

^{** 100%} tested in 36% rating



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Electrical Characteristics @ Tc =25°C (unless otherwise specified)

Parameter	Symbol	Conditions	Conditions		Тур.	Max.	Unit
OFF Characteristics							
Drain-Source Breakdown Voltage	BVDSS	V _G s=0V , I _D =0.1mA		1200	-	-	V
Zoro Cata Valtaga Drain Current	loss	V _{DS} =1200V V _{GS} =0V	TJ=25°C	-	0.5	100	μА
Zero Gate Voltage Drain Current			TJ=175℃	-	5	200	
Gate-Source Leakage Current	Igss	V _{GS} =15V , V _{DS} =0V		-	5	100	nA
Cate-course Ecanage Current		V _{GS} =-4V , V _{DS} =0V		-100	-5	-	IIA
ON Characteristics							
Gate Threshold Voltage ***	V _{GS(th)}	V _{DS} = V _{GS} , I _D =20mA	TJ=25°C	2.2	3.0	4.2	V
Gate Threshold Voltage			TJ=175℃	-	2.2	-	
Drain-Source On-State Resistance	RDS(on)	V _{GS} =15V , I _D =50A	TJ=25°C	-	18	24	mΩ
Drain-Godice Off-State Resistance			T」=175℃	-	32	-	
Transconductance	g fs	V _{DS} = 20V , I _D = 50A	T」=25°C	-	43	-	S
Transconductance		V 55 25 V 15 00/1	TJ=175℃	-	41	-	
Internal Gate Resistance	RG(int.)	f=1MHz , ID=0A		-	1.2	-	Ω
Dynamic Characteristics							
Input Capacitance	Ciss	V _{DS} = 1000V V _{GS} = 0V f = 100kHz V _{AC} = 25mV		-	4800	-	pF
Output Capacitance	Coss			-	168	-	
Reverse Transfer Capacitance	Crss			-	16	-	
Coss Stored Energy	Eoss			-	100	-	μJ
Turn-On Switching Energy	Eon	V _{DS} =800V , V _{GS} =-4/+15V		-	590	-	
Turn-Off Switching Energy	Eoff	$-I_D = 50A$, $R_{G(ext)} = 2.0Ω$ L=200μH		-	130	-	μJ
Switching Characteristics				·	'		'
Turn-On Delay Time	td(on)			-	20	-	
Rise Time	tr	V _{DS} =800V , V _{GS} =-4/+1	5V	-	28	-	- ns
Turn-Off Delay Time	td(off)	$I_D = 50A$, $R_{G(ext)} = 2.0Ω$ L=200μH		-	43	-	
Fall Time	tf	·		-	13	-	
Total Gate Charge	Qg	V _{DS} =800V V _{GS} =-4/+15V I _D =50A		-	210	-	
Gate to Source Charge	Qgs			-	56	-	nC
Gate to Drain Charge	Qgd			-	85	-	
Body Diode Characteristics				<u> </u>	<u> </u>		
Inverse Diode Forward Voltage	.,	V _{GS} =-4V , I _{SD} =40A	TJ=25°C	-	4.4	-	V
Inverse Diode Forward Voltage	Vsp		T」=175℃	-	3.9	-	V
Continuous Diode Forward Current	Is	V _{GS} =-4V , T _J =25°C	•	-	100	-	А
Reverse Recovery Time	Trr	I_{SD} =50A , V_{GS} =-4V V_R =800V , $R_{G(ext)}$ =10 Ω dif/dt=1750A/ μ s L=200 μ H		-	25	-	ns
Reverse Recovery Charge	Qrr			-	450	-	nC
Peak Reverse Recovery Current	Irrm			-	33	-	Α
Thermal Resistance							
Thermal Resistance, Junction-to-Case	RθJc			-	0.26	0.32	°C/W

^{***} Turn-off with -4V gate bias is highly recommended



Fig 1. Output Characteristics, T_J = -40°C

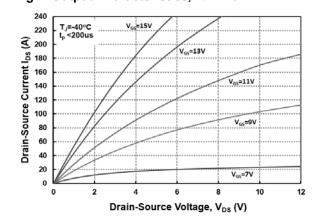


Fig 2. Output Characteristics, T_J = 25°C

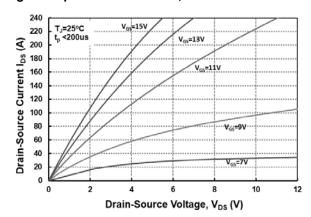


Fig 3. Output Characteristics, T_J = 175°C

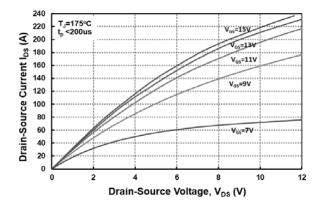


Fig 4. Normalized On-Resistance vs. Temperature

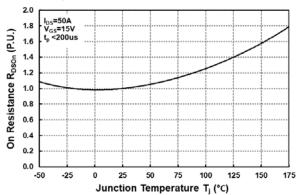


Fig 5. On-Resistance vs. Drain Current for Various Temperatures

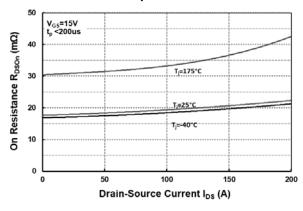
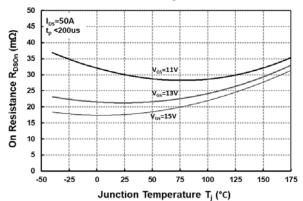


Fig 6. On-Resistance vs. Temperature for Various Gate Voltage



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Fig 7. Transfer Characteristic for Various Junction Temperatures

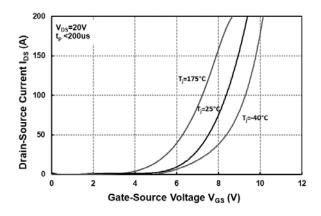


Fig 9. Body Diode Characteristics @ 25°C

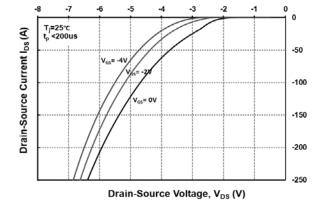
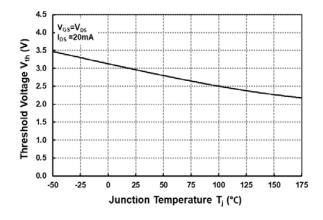


Fig 11. Threshold Voltage vs. Temperature



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Fig 8.Body Diode Characteristics @ -40°C

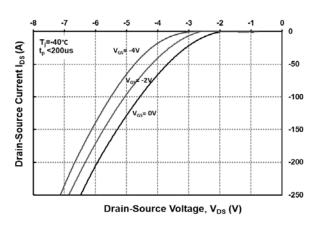


Fig 10. Body Diode Characteristics @ 175°C

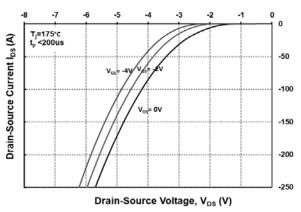
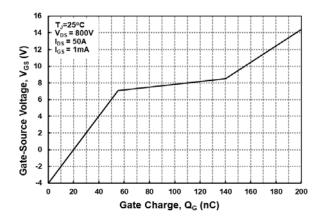


Fig 12. Gate Charge Characteristics



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Fig 13. 3rd Quadrant Characteristics @ -40°C

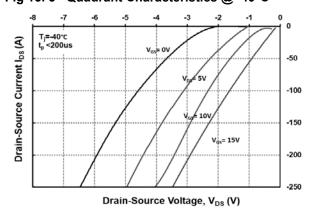


Fig 14. 3rd Quadrant Characteristics @ 25°C

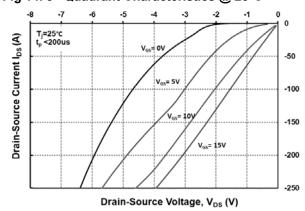


Fig 15. 3rd Quadrant Characteristics @ 175°C

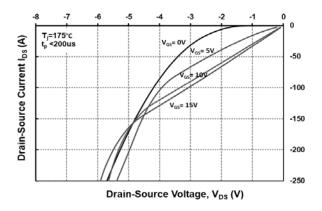


Fig 16. Output Capacitor Stored Energy

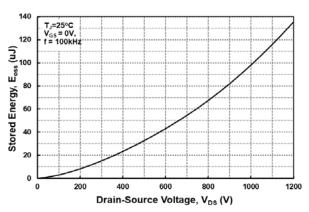


Fig 17. Capacitances vs. Drain-Source Voltage (0-200V)

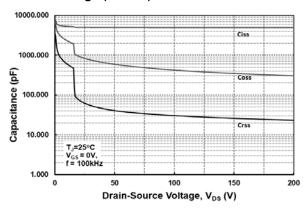
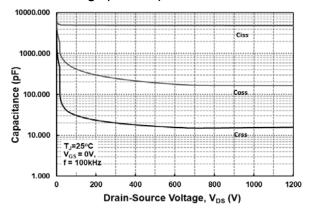


Fig 18. Capacitances vs. Drain-Source Voltage (0-1200V)



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Fig 19. Continuous Drain Current Derating vs. Case Temperature

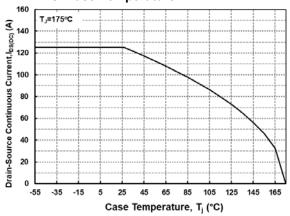


Fig 20. Maximum Power Dissipation Derating vs. Case Temperature

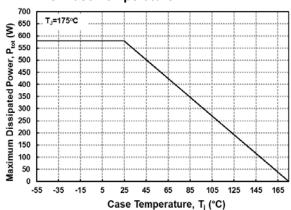


Fig 21. Transient Thermal Impedance (Junction - Case)

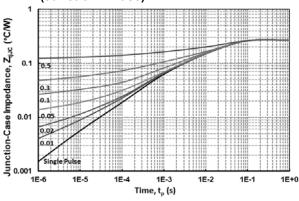


Fig 22. Safe Operating Area

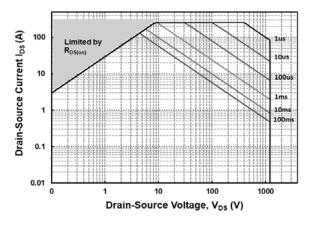


Fig 23. Clamped Inductive Switching Energy vs Drain Current (VDD = 800V)

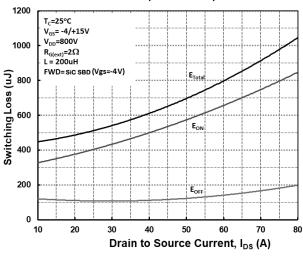
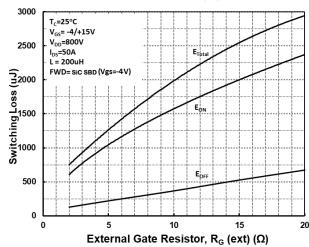


Fig 24. Clamped Inductive Switching Energy vs External Gate Resistor RG(ext)



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Fig 25. Switching Times vs Drain Current $(V_{DD} = 800V)$

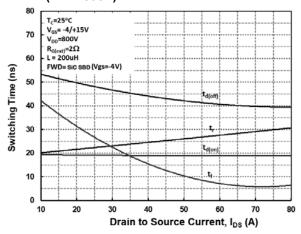
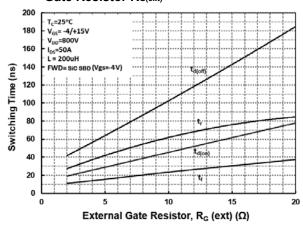


Fig 26. Switching Times vs External Gate Resistor R_{G(ext)}



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